Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/678,061	IMAI ET AL.
Examiner	Art Unit
Chris C. Chu	2815

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	754 and 756	7/21/2005	C.C.
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	7/21/2005	C.C.		
Consulated with Bill Baumeister 257/754, 756, 750 - 757 & 296 - 313	7/20/2005	C.C.		
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